INTEGRATED CIRCUITS

DATA SHEET

74F379AQuad register

Product specification

1996 Mar 12

IC15 Data Handbook





Quad register 74F379A

FEATURES

- Edge-triggered D-type inputs
- Buffered positive edge-triggered clock
- Buffered common enable input
- True and complementary outputs
- Offers light loading PNP inputs ($I_{IL} = -20\mu A$)

DESCRIPTION

The 74F379A is a 4–bit register with buffered common enable (\overline{E}). This device is similar to the 74F175A but features the common enable rather than common master reset.

TYPE	TYPICAL f _{max}	TYPICAL SUPPLY CURRENT (TOTAL)				
74F379A	200MHz	29mA				

ORDERING INFORMATION

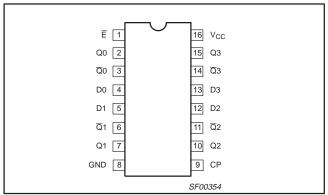
	ORDER CODE		
DESCRIPTION	COMMERCIAL RANGE $V_{CC} = 5V \pm 10\%$, $T_{amb} = 0^{\circ}C$ to $+70^{\circ}C$	PKG, DWG. #	
16-pin plastic DIP	N74F379AN	SOT38-4	
16-pin plastic SO	N74F379AD	SOT109-1	

INPUT AND OUTPUT LOADING AND FAN OUT TABLE

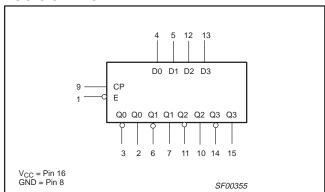
TYPE	PINS	DESCRIPTION	74F (U.L.) HIGH/ LOW	LOAD VALUE HIGH/LOW
	D0 – D3	Data inputs	1.0/0.033	20μΑ/20μΑ
74F379A	СР	Clock pulse input (active rising edge)	1.0/0.033	20μΑ/20μΑ
	Ē	Enable input (active low)	1.0/0.033	20μΑ/20μΑ
	Q0 – Q3	True outputs	50/33	1.0mA/20mA
	$\overline{Q}0 - \overline{Q}3$	Complementary outputs	50/33	15mA/20mA

Note to input and output loading and fan out table

PIN CONFIGURATION



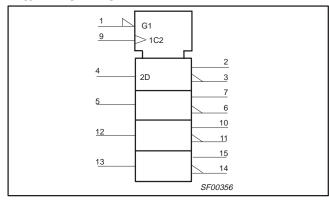
LOGIC SYMBOL



^{1.} One (1.0) FAST unit load is defined as: $20\mu A$ in the high state and 0.6mA in the low state.

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IEC/IEEE SYMBOL



FUNCTION TABLE

	INPUTS	OUTPUTS	OUTPUT		
Ē	СР	Dn	Qn	Qn	
Н	↑	Х	NC	NC	
L	↑	h	Н	L	
L	↑	I	L	Н	

Notes to function table

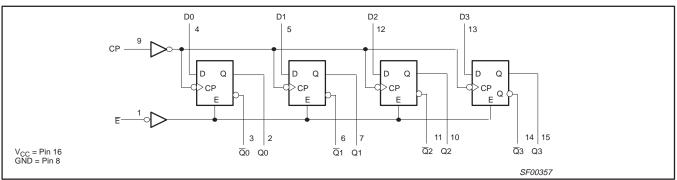
H = High-voltage level

High-voltage level
High state must be present one setup time
before the low-to-high clock transition
Low-voltage level
Low state must be present one setup time
before the low-to-high clock transition

NC= No change Don't care

= Low-to-high clock transition

LOGIC DIAGRAM



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ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limit set forth in this table may impair the useful life of the device.

Unless otherwise noted these limits are over the operating free air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V _{CC}	Supply voltage	-0.5 to +7.0	V
V _{IN}	Input voltage	-0.5 to +7.0	V
I _{IN}	Input current	-30 to +5	mA
V _{OUT}	Voltage applied to output in high output state	–0.5 to V _{CC}	V
l _{OUT}	Current applied to output in low output state	40	mA
T _{amb}	Operating free air temperature range	0 to +70	°C
T _{stg}	Storage temperature range	-65 to +150	°C

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER			UNIT	
		MIN	NOM	MAX	
V _{CC}	Supply voltage	4.5	5.0	5.5	V
V _{IH}	High-level input voltage	2.0			V
V _{IL}	Low-level input voltage			0.8	V
I _{lk}	Input clamp current			-18	mA
Іон	High-level output current			-1	mA
I _{OL}	Low-level output current			20	mA
T _{amb}	Operating free air temperature range	0		+70	°C

DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	PARAMETER	TEST		UNIT			
		CONDITIONS ¹	MIN	TYP ²	MAX		
V _{OH}	High-level output voltage	V _{CC} = MIN, V _{IL} = MAX,	±10%V _{CC}	2.5			V
		V _{IH} = MIN, I _{OH} = MAX	±5%V _{CC}	2.7	3.4		V
V _{OL}	Low-level output voltage	V _{CC} = MIN, V _{IL} = MAX,	±10%V _{CC}		0.35	0.50	V
		$V_{IH} = MIN, I_{OL} = MAX$	±5%V _{CC}		0.35	0.50	V
V _{IK}	Input clamp voltage	$V_{CC} = MIN, I_I = I_{IK}$			-0.73	-1.2	V
I _I	Input current at maximum input voltage	$V_{CC} = 0.0V, V_I = 7.0V$				100	μА
I _{IH}	High-level input current	$V_{CC} = MAX, V_I = 2.7V$				20	μА
I _{IL}	Low-level input current					-20	μА
I _{OS}	Short-circuit output current3	V _{CC} = MAX	·	-60		-150	mA
Icc	Supply current (total)				29	42	mA

Notes to DC electrical characteristics

- 1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.
- 2. All typical values are at $V_{CC} = 5V$, $T_{amb} = 25^{\circ}C$.
- 3. Not more than one output should be shorted at a time. For testing I_{OS}, the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

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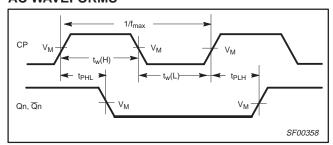
AC ELECTRICAL CHARACTERISTICS

			Tai	_{mb} = +25	°C	$T_{amb} = 0^{\circ}$		
SYMBOL	PARAMETER	TEST CONDITION	$V_{CC} = +5.0V$ $C_{L} = 50pF, R_{L} = 500\Omega$			$V_{CC} = +5.$ $C_{L} = 50pF,$	UNIT	
			MIN	TYP	MAX	MIN	MAX	
f _{max}	Maximum clock frequency	Waveform 1	175	200		155		MHz
t _{PLH} t _{PHL}	Propagation delay CP to Qn or $\overline{\mathbb{Q}}$ n	Waveform 1	2.0 4.0	3.5 5.5	6.5 8.0	2.0 3.5	7.0 8.5	ns

AC SETUP REQUIREMENTS

					LIN	IITS		
SYMBOL	PARAMETER	TEST CONDITION	V	_{mb} = +25 _{CC} = +5.0 0pF, R _L :	V	$T_{amb} = 0^{\circ}C$ $V_{CC} = +5.$ $C_{L} = 50pF,$	UNIT	
			MIN	TYP	MAX	MIN	MAX	
t _{su} (H) t _{su} (L)	Setup time, high or low level Dn to CP	Waveform 2	3.0 3.0			3.5 3.5		ns
t _h (H) t _h (L)	Hold time, high or low level Dn to CP	Waveform 2	0			0 0		ns
t _{su} (H) t _{su} (L)	Setup time, high or low level E to CP	Waveform 2	4.0 3.5			4.5 4.0		ns
t _h (H) t _h (L)	Hold time, high or low level E to CP	Waveform 2	0 0			0 0		ns
t _w (H) t _w (L)	CP Pulse width, high or low	Waveform 1	3.5 4.5			3.5 4.5		ns

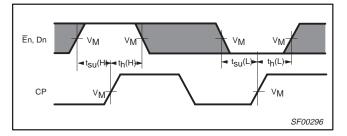
AC WAVEFORMS



Waveform 1. Propagation delay for clock input to output, clock pulse widths, and maximum clock frequency



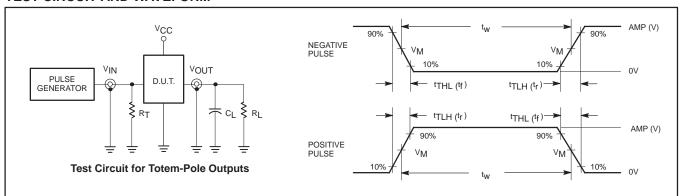
- 1. For all waveforms, $V_M = 1.5V$.
- The shaded areas indicate when the input is permitted to change for predictable output performance.



Waveform 2. Data and enable setup time and hold times

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TEST CIRCUIT AND WAVEFORM



DEFINITIONS:

R_L = Load resistor; see AC ELECTRICAL CHARACTERISTICS for value.

C_L = Load capacitance includes jig and probe capacitance; see AC ELECTRICAL CHARACTERISTICS for value.

R_T = Termination resistance should be equal to Z_{OUT} of

pulse generators.

Input Pulse Definition

family	INP	INPUT PULSE REQUIREMENTS									
family	amplitude	V_{M}	rep. rate	t _w t _{TLH}		t _{THL}					
74F	74F 3.0V		1MHz	500ns	2.5ns	2.5ns					

SF00006

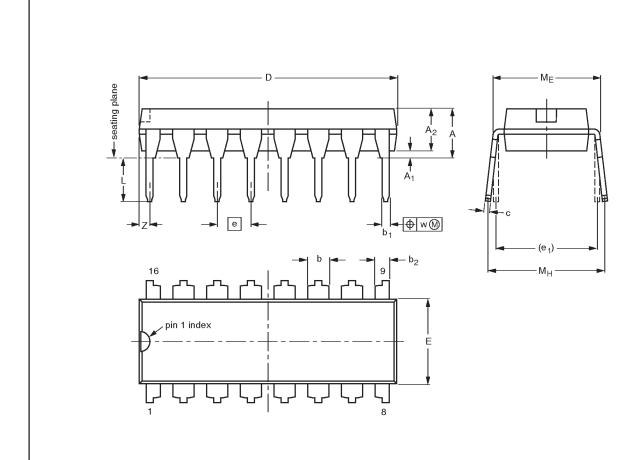
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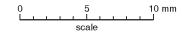
Quad register

DIP16: plastic dual in-line package; 16 leads (300 mil)

SOT38-4

74F379A





DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	b ₂	С	D ⁽¹⁾	E (1)	е	e ₁	L	ME	M _H	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	1.25 0.85	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	0.76
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.049 0.033	0.014 0.009	0.77 0.73	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.030

Note

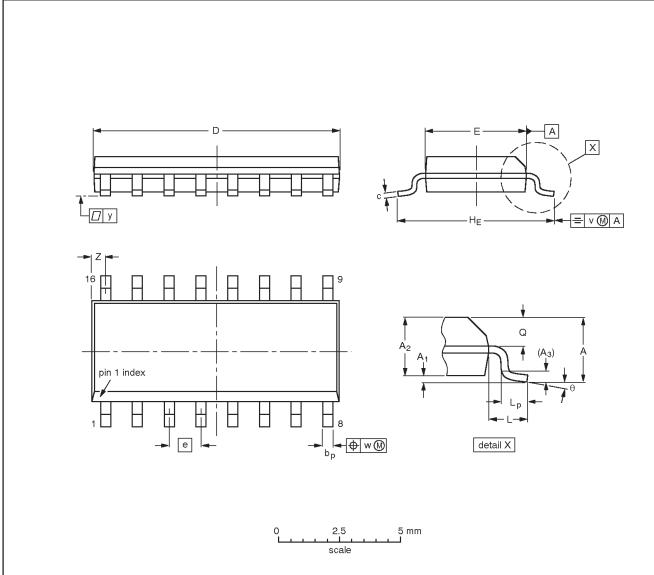
1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SOT38-4					92-11-17 95-01-14	

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SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	>	w	у	Z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	10.0 9.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01		0.0100 0.0075	0.39 0.38	0.16 0.15	0.050	0.244 0.228	0.041	0.039 0.016		0.01	0.01	0.004	0.028 0.012	0°

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ	PROJECTION	1330E DATE	
SOT109-1	076E07S	MS-012AC			95-01-23 97-05-22	

Quad register 74F379A

NOTES

Quad register 74F379A

Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
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